

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
09/961,423	SOHMA ET AL.	
Examiner	Art Unit	
Marc R. Filipczyk	2163	

	SEARCHED			
Class	Subclass	Date	Examiner	
update	search	1/27/2006	MF	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
707	200	1/27/2006	MF		
707	1, 3, 100	1/27/2006	MF		
707	104.1	1/27/2006	MF		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched East, CiteSeer, IEEE, Scirus; attach/append/associate meta data, content/category, modify, manage, display meta data	1/27/2006	MF
class search 707 and sub (1-3, 101, 104.1, 200); consulted Coby (AU2161) and Alam (AU2166)	1/27/2006	MF
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